



IEC Standard Articulated Test Probe is a precision test probe made according to Figure 2 (Fig. 2) of the IEC 61032 (Test probe B) and is used to simulate a human finger. It is also used by the standards of CSA, IRAM, UL, IEC 60335, IRAM 4220-1 and in most of the rules involved in the verification of accessibility to live parts.

The Jointed Test Finger was made on stainless steel and Polyamide handle.

Material: Stainless Steel.

Handle: Polyamide.

Finish: Chrome plating.

According to: IEC 61032, IEC 60335-1, IEC 60529-2001, IRAM 4220-1, SASO/IEC 60335-1, SASO IEC 60950, IEC 60950/EN60950.

Thrust: 10N

